

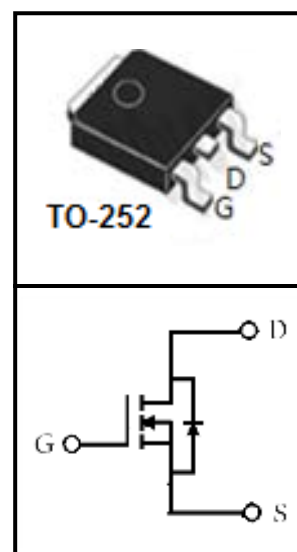
25V N-Channel Trench MOSFET

FEATURES

- Super Low Gate Charge
- 100% EAS Guaranteed
- RoHS compliant
- Green Device Available
- Excellent CdV/dt effect decline
- Advanced high cell density Trench technology

APPLICATIONS

- Load Switching
- Power Motor Controls
- High Frequency Isolated DC-DC Converters with Synchronous Rectification for Industrial



Device Marking and Package Information

Device	Package	Marking
CTD02N004	TO-252	CTD02N004

Absolute Maximum Ratings at $T_J = 25^{\circ}\text{C}$ unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-Source Voltage ($V_{GS} = 0\text{V}$)	V_{DSS}	25	V
Continuous Drain Current $T_C = 25^{\circ}\text{C}$ (note1)	I_D	90	A
Continuous Drain Current $T_C = 100^{\circ}\text{C}$ (note1)		65	A
Pulsed Drain Current (note2)	I_{DM}	340	A
Gate Source Voltage	V_{GSS}	± 12	V
Single Pulse Avalanche Energy (note3)	E_{AS}	340	mJ
Power Dissipation $T_C = 25^{\circ}\text{C}$ (note4)	P_D	87	W
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55~+175	$^{\circ}\text{C}$

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-Case (note1)	$R_{\theta JC}$	1.72	$^{\circ}\text{C/W}$

Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
Static						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	25	--	--	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 20V, V _{GS} = 0V, T _J = 25°C	--	--	1	uA
		V _{DS} = 20V, V _{GS} = 0V, T _J = 100°C	--	--	5	uA
Gate-Source Leakage	I _{GSS}	V _{GS} = ±12V	--	--	±100	nA
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	0.4	0.75	1.2	V
Drain-Source On-Resistance (note2)	R _{DS(on)}	V _{GS} = 10V, I _D = 30A	--	3.1	4	mΩ
		V _{GS} = 4.5V, I _D = 20A	--	3.3	4.5	mΩ
		V _{GS} = 2.5V, I _D = 15A	--	5.5	8	mΩ
Dynamic						
Input Capacitance	C _{iss}	V _{GS} = 0V, V _{DS} = 15V, f = 1.0MHz	--	2813	--	pF
Output Capacitance	C _{oss}		--	355	--	
Reverse Transfer Capacitance	C _{rss}		--	263	--	
Total Gate Charge (4.5V)	Q _g	V _{DD} = 10V, I _D = 12A, V _{GS} = 4.5V	--	33	--	nC
Gate-Source Charge	Q _{gs}		--	4	--	
Gate-Drain Charge	Q _{gd}		--	14	--	
Turn-on Delay Time	t _{d(on)}	V _{DS} = 15V, R _L = 0.75Ω, V _{GS} = 4.5V,R _G = 3Ω	--	18	--	ns
Turn-on Rise Time	t _r		--	53	--	
Turn-off Delay Time	t _{d(off)}		--	76	--	
Turn-off Fall Time	t _f		--	28	--	
Body Diode Characteristics						
Continuous Body Diode Current	I _S	T _C = 25 °C	--	--	90	A
Body Diode Voltage	V _{SD}	T _J = 25°C, I _{SD} = 5A, V _{GS} = 0V	--	--	1.2	V
Reverse Recovery Time	t _{rr}	TJ=25°C I _F =30A, di/dt=100A/μs	--	25	--	nS
Reverse Recovery Charge	Q _{rr}		--	13	--	nC

Notes

1. The data tested by surface mounted on a 1 inch² FR-4 board with 20Z copper.
2. The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
3. The EAS data shows Max. rating . The test condition is $V_{DD} = 25V, V_{GS} = 10V, L = 0.1mH$
4. The power dissipation is limited by 175°C junction temperature
5. The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

Typical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

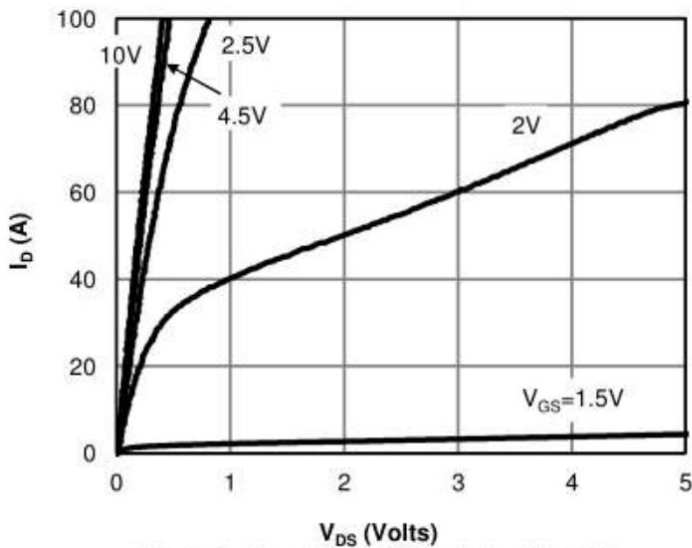


Fig 1: On-Region Characteristics (Note E)

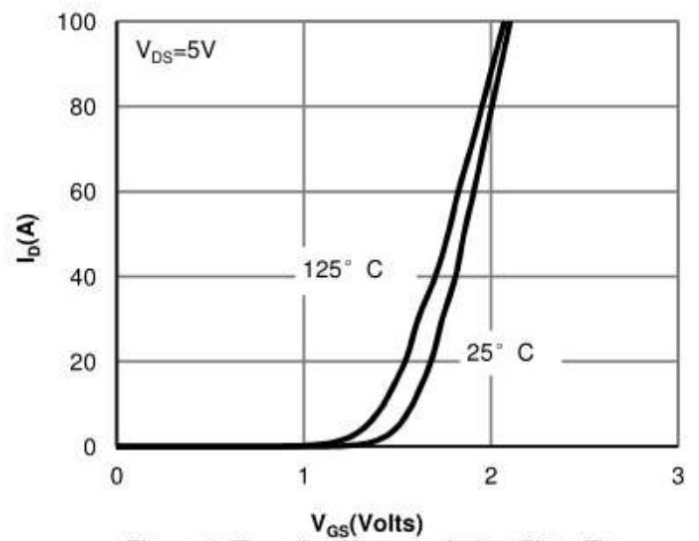


Figure 2: Transfer Characteristics (Note E)

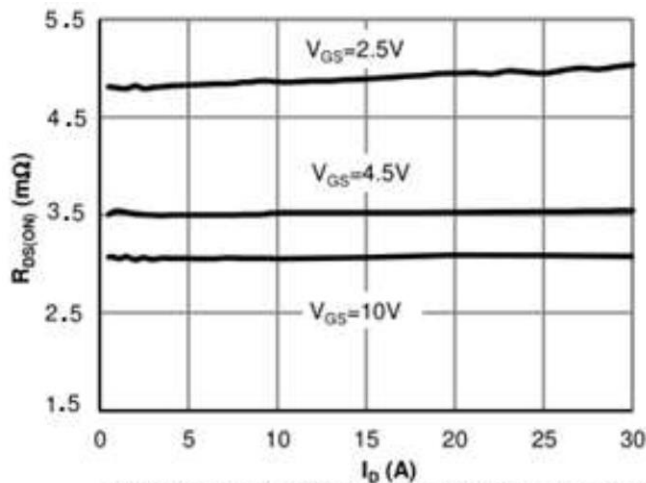


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

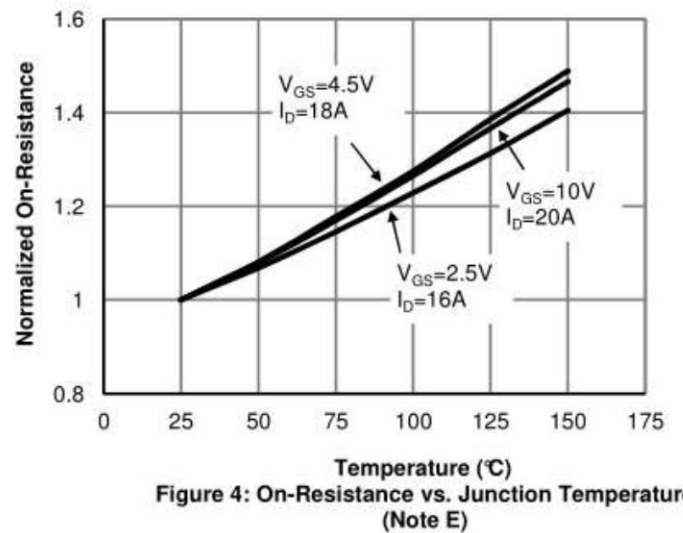


Figure 4: On-Resistance vs. Junction Temperature (Note E)

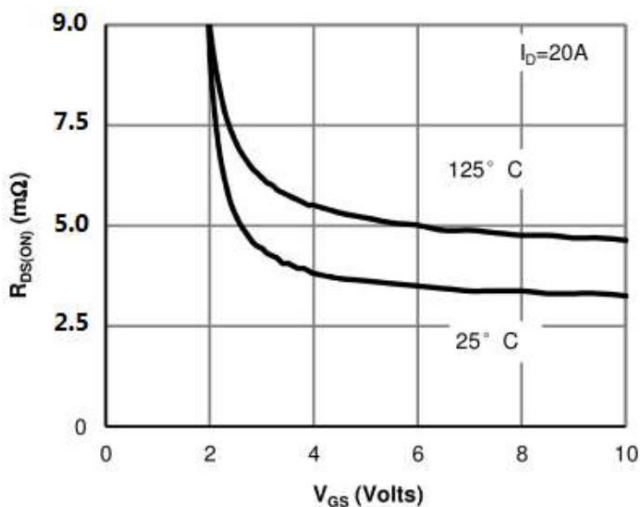


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

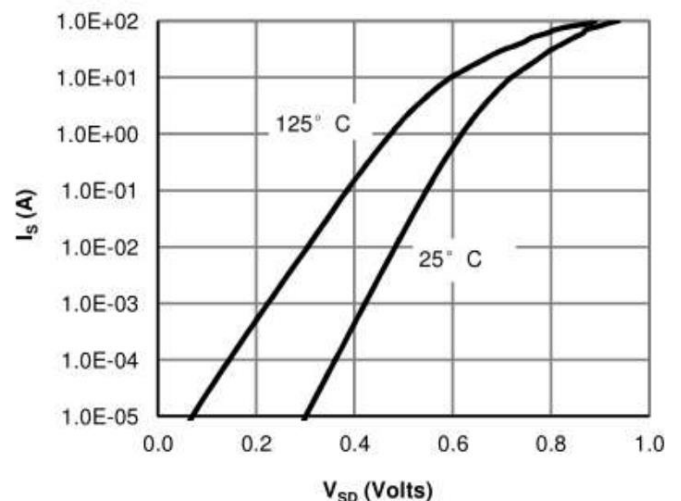


Figure 6: Body-Diode Characteristics (Note E)

Typical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

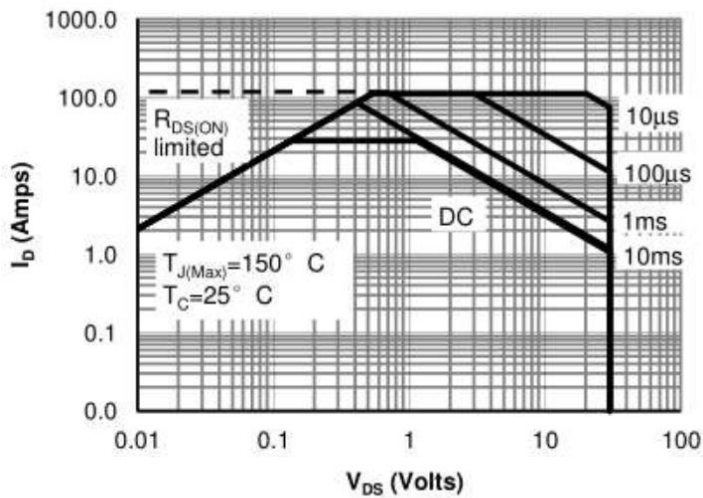


Figure 7: Maximum Forward Biased Safe Operating Area (Note F)

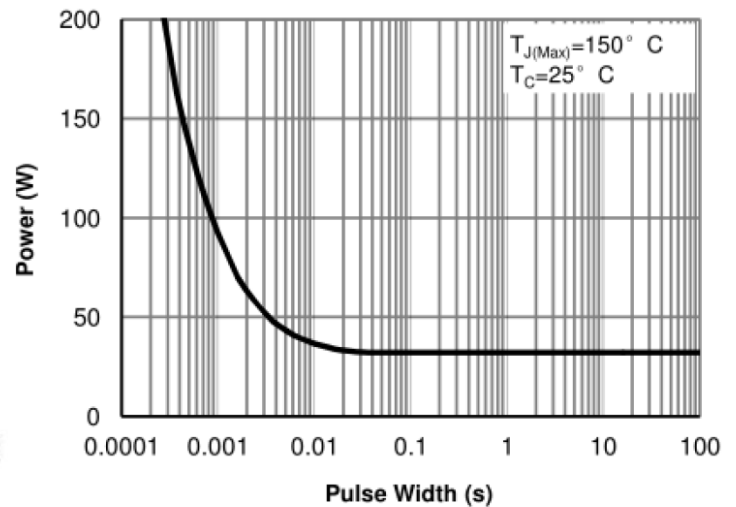


Figure 8: Single Pulse Power Rating Junction-to-Case (Note F)

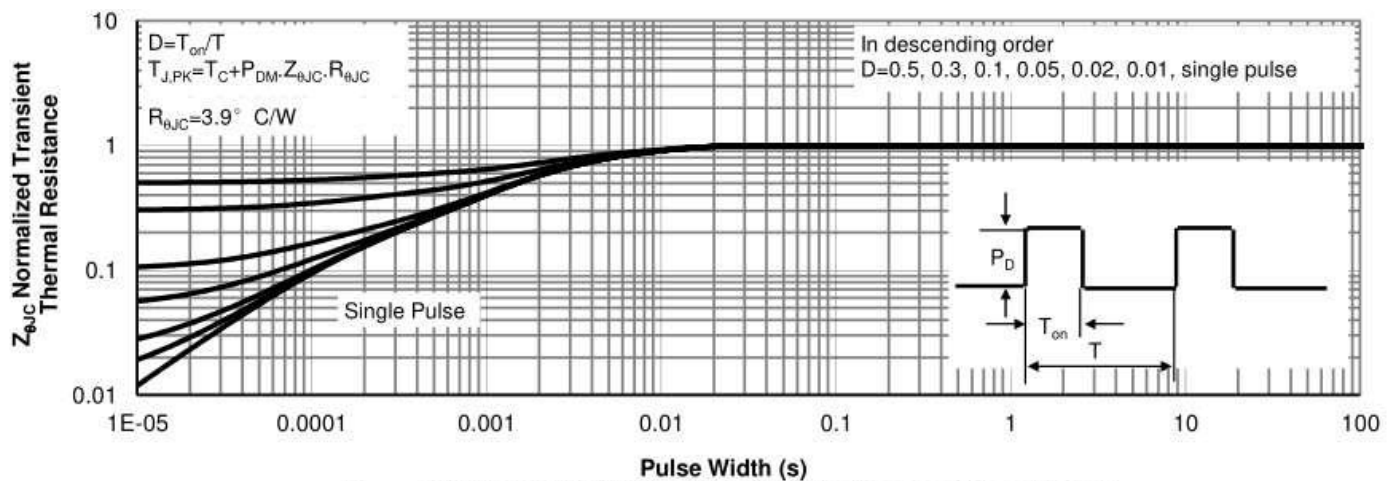
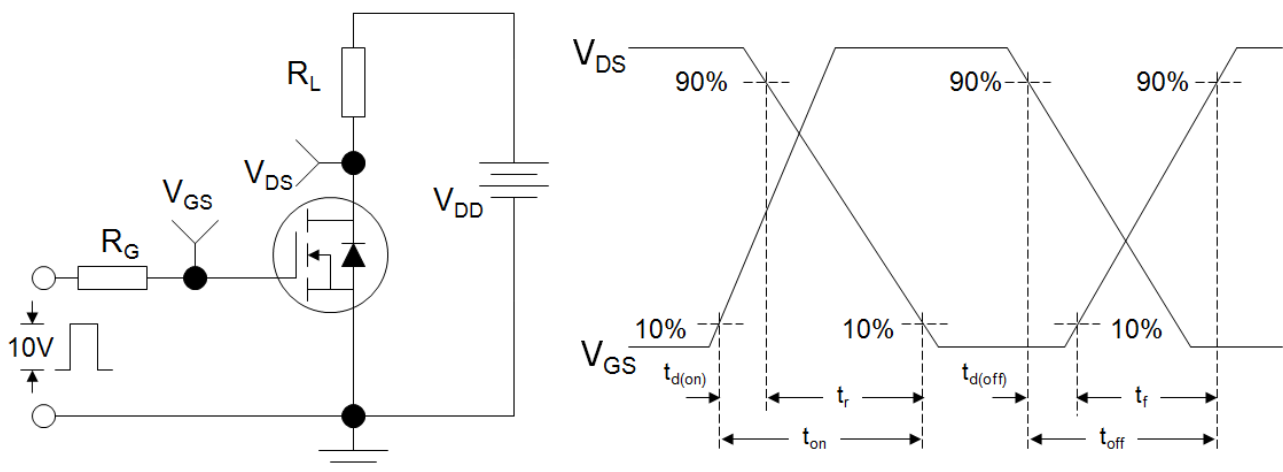
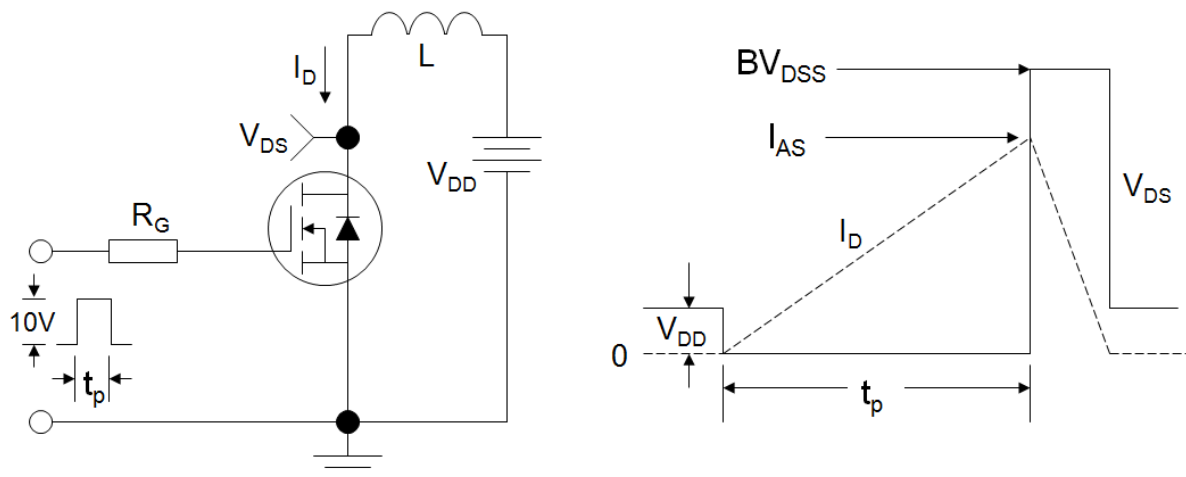
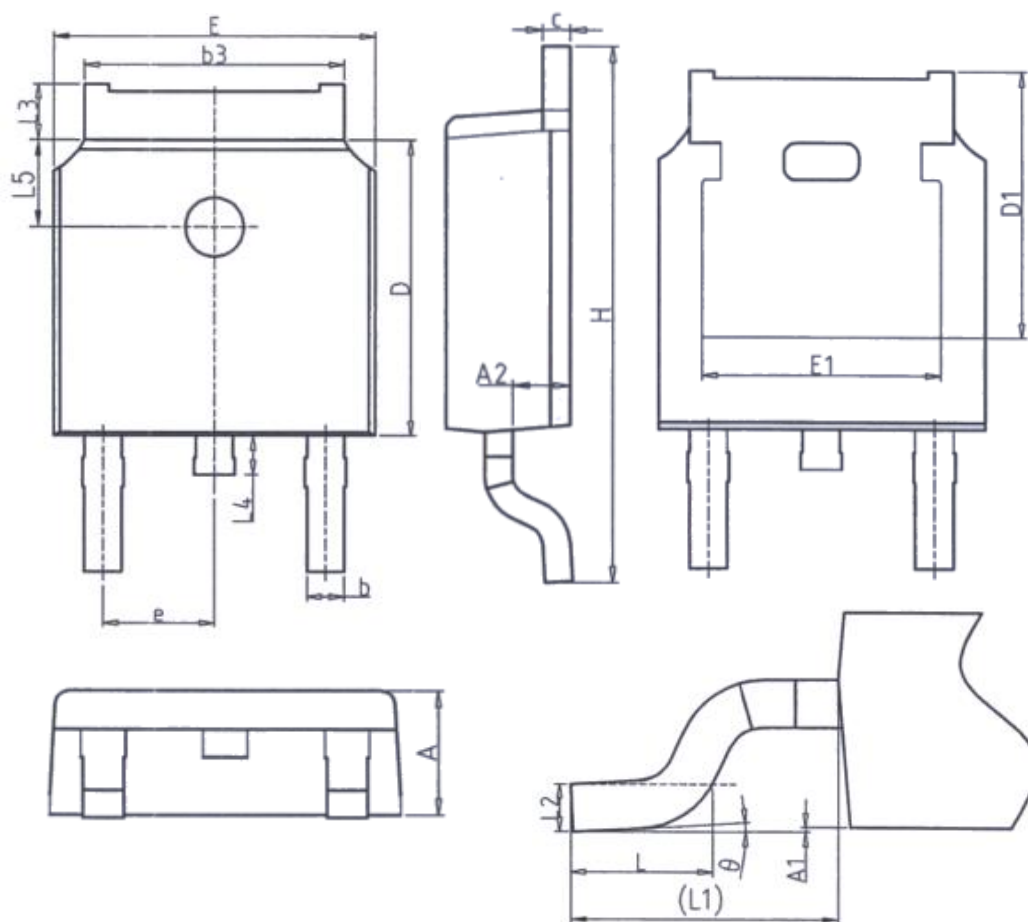


Figure 9: Normalized Maximum Transient Thermal Impedance (Note F)

Figure A: Gate Charge Test Circuit and Waveform

Figure B: Resistive Switching Test Circuit and Waveform

Figure C: Unclamped Inductive Switching Test Circuit and Waveform


TO-252



Unit: mm		
Symbol	Min.	Max.
A	2.20	2.40
A1	0.00	0.20
A2	0.97	1.17
b	0.68	0.90
b3	5.20	5.50
c	0.43	0.63
D	5.98	6.22
D1	5.30REF	
E	6.40	6.80
E1	4.63	-

Unit: mm		
Symbol	Min.	Max.
e	2.286BSC	
H	9.40	10.50
L	1.38	1.75
L1	2.90REF	
L2	0.51BSC	
L3	0.88	1.28
L4	-	1.00
L5	1.65	1.95
θ	0°	8°

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